

AMENDMENT TO THE CLAIMS:

Please cancel claims 28, 30, 32-34, 36-37, 39, 40, 42, 43, 45, 46, 48, 49, 51, 52, 54, 55, 57, 58, 60, 61, 63, 64, 66, 67, and 70, without prejudice, and amend claims 26, 29, 31, 35, 38, 41, 44, 47, and 50, as set forth below.

This listing of claims will replace all prior versions and listings of claims in the Application:

Claim 1 (original): A photodiode comprising:

a conductive film having: an aperture having a diameter smaller than wavelength of incident light, and a periodic structure provided around said aperture for producing a resonant state by an excited surface plasmon in a film surface of said conductive film by means of the incident light to said film surface; and

a semiconductor layer provided in a vicinity of said aperture of said conductive film and in contact with said conductive film;

wherein said photodiode detects near-field light that is generated at an interface between said conductive film and said semiconductor layer by said excited surface plasmon.

Claim 2 (original): The photodiode according to claim 1, wherein said conductive film is a metal film through which said incident light does not pass at locations other than said aperture.

Claim 3 (previously presented): The photodiode according to claim 1, wherein a region in which a Schottky barrier formed by said conductive film and said semiconductor layer appears substantially matches a region of generation of said near-field light.

Claims 4-25 (canceled)

Claim 26 (currently amended): The photodiode according to claim [[2]]1, wherein a region in which a Schottky barrier formed by said conductive film and said semiconductor layer appears substantially matches a region of generation of said near-field light.

Claim 27 (previously presented): The photodiode according to claim 1, wherein said periodic structure is composed of surface irregularities having a period in a direction of increasing distance from said aperture.

Claim 28 (cancelled)

Claim 29 (currently amended): The [[A]] photodiode according to claim 1, wherein said conductive film has a ~~comprising:~~

~~——a conductive film having a first surface and a second surface, said and including: an aperture having a diameter smaller than wavelength of incident light that is formed from said first surface side; and [[a]] said periodic structure is composed of surface irregularities having a period in a direction of increasing distance from said aperture;~~

~~a first said semiconductor layer is a first semiconductive layer of one conductive type provided in a vicinity of said aperture of said conductive film and in contact with the second surface of said conductive film; and~~

said photodiode further includes a second semiconductor layer of said one conductive type in which concentration of impurities is higher than in said first semiconductor layer, and which contacts a surface of said first semiconductor layer that is opposite to another surface in contact with the second surface of said conductive film.

Claim 30 (cancelled)

Claim 31 (currently amended): The photodiode according to claim [[29]] 1, wherein said periodic structure is composed of concentric grooves that take said aperture as center.

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Claims 32 - 34 (cancelled)

Claim 35 (currently amended): The photodiode according to claim [[29]] 1, wherein said aperture has a bottom surface portion that is a part of said conductive film.

Claims 36 and 37 (cancelled)

Claim 38 (currently amended): The photodiode according to claim [[29]] 1, wherein a scattering member composed of a conductive material for scattering light is arranged in said aperture.

Claims 39 and 40 (cancelled)

Claim 41 (currently amended): The photodiode according to claim 35, comprising a scattering member composed of conductive material for scattering light, said scattering member being embedded in said ~~second~~ semiconductor layer side from an interface between said bottom surface portion and said ~~second~~ semiconductor layer corresponding to the position of said aperture.

Claims 42 and 43 (cancelled)

Claim 44 (currently amended): The photodiode according to claim [[29]] 1, wherein said aperture penetrates said conductive film and reaches said ~~second~~ semiconductor layer, and of said conductive film, a periphery around said aperture contacts said ~~second~~ semiconductor layer.

Claims 45 and 46 (cancelled)

Claim 47 (currently amended): The photodiode according to claim 44, wherein a scattering member composed of a conductive material for scattering light is embedded in a surface of said ~~second~~ semiconductor layer corresponding to the position of said aperture.

Claims 48 and 49 (cancelled)

Claim 50 (currently amended): The photodiode according to claim 29, wherein a transparent film having an index of refraction substantially equal to that of said ~~second~~ semiconductor layer is provided on said first surface of said conductive film.

Claims 51 and 52 (cancelled)

Claim 53 (previously presented): The photodiode according to claim 50, further comprising an antireflection film for incident light provided on said transparent film.

Claims 54 and 55 (cancelled)

Claim 56 (previously presented): The photodiode according to claim 29, wherein said conductive film is a metal film and the diameter of said aperture is at least $1/10$ but no greater than $1/2$ the wavelength of said incident light.

Claims 57 and 58 (cancelled)

Claim 59 (previously presented): The photodiode according to claim 56, wherein the period of said periodic structure is equal to or less than the wavelength of said incident light.

Claims 60 and 61 (cancelled)

Claim 62 (previously presented): The photodiode according to claim 56, wherein the period of said periodic structure is set to a resonant wavelength of the surface plasmon excited on said conductive film by said incident light.

Claims 63 and 64 (cancelled)

Claim 65 (previously presented): The photodiode according to claim 56, wherein said metal film has a thickness no greater than 1000 nm but at least 100 nm at concave portions of said periodic structure, and a depth of said surface irregularities is at least 20 nm but no greater than 200 nm.

Claims 66 and 67 (cancelled)

Claim 68 (previously presented): The photodiode according to claim 32, wherein a thickness of said second semiconductor layer interposed between said first semiconductor layer and said conductive film is at least 50 nm but no greater than 100 nm.

Claim 69 (previously presented): The photodiode according to claim 33, wherein a thickness of said second semiconductor layer interposed between said first semiconductor layer and said conductive film is at least 50 nm but no greater than 100 nm.

Claim 70 (cancelled)

Claim 71 (withdrawn): A method for fabricating a photodiode which has a conductive film having an aperture and periodic surface irregularities that takes said aperture as center, and a semiconductor layer joined to said conductive film at a position of a bottom of said aperture, the method comprising the steps of:

defining and forming said semiconductor layer such that a region for carrying out photoelectric conversion is limited to a position corresponding to the bottom of said aperture;

forming said conductive film; and

forming said aperture and said surface irregularities in said conductive film such that said aperture and said surface irregularities are matched to said region.

Claim 72 (previously presented): An optical module comprising:

a photodiode according to claim 1 for detecting signal light emitted from an optical fiber to supply it as an electrical signal; and

a preamplifier for amplifying the electrical signal.

Claim 73 (previously presented): An optical module comprising:

a photodiode according to claim 29 for detecting signal light emitted from an optical fiber to supply it as an electrical signal; and

a preamplifier for amplifying the electrical signal.

Claim 74 (previously presented): The optical module according to claim 72, comprising:

a case; and

an optical coupler for optically coupling said optical fiber and said photodiode;

wherein said photodiode and said preamplifier are accommodated in said case.

Claim 75 (previously presented): The optical module according to claim 73, comprising:

a case; and

an optical coupler for optically coupling said optical fiber and said photodiode;

wherein said photodiode and said preamplifier are accommodated in said case.

Claim 76 (previously presented): An optical interconnection module comprising:

a photodiode according to claim 1 for receiving incidence of light emitted from a first optical fiber to generate a first signal current;

a light source for generating a signal light that is irradiated into a second optical fiber;

and

a mounting board on which said photodiode and said light source are arranged;

wherein said first signal current is supplied to an LSI, and said light source generates the signal light in accordance with the second signal current from said LSI.

Claim 77 (previously presented): An optical interconnection module comprising:

a photodiode according to claim 29 for receiving incidence of light emitted from a first optical fiber to generate a first signal current;

a light source for generating a signal light that is irradiated into a second optical fiber;

and

a mounting board on which said photodiode and said light source are arranged;

wherein said first signal current is supplied to an LSI, and said light source generates the signal light in accordance with the second signal current from said LSI.

Claim 78 (previously presented): The optical interconnection module according to claim 76, further comprising:

a first optical coupler for optically coupling said first optical fiber and said photodiode;
and

a second optical coupler for optically coupling said light source and said second optical fiber.

Claim 79 (previously presented): The optical interconnection module according to claim 77, further comprising:

a first optical coupler for optically coupling said first optical fiber and said photodiode;
and

a second optical coupler for optically coupling said light source and said second optical fiber.

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